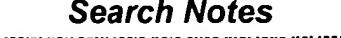


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/726,382	YEH ET AL.	
	Examiner	Art Unit	
	James A. Dudek	2871	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner